

OptiMOS® Power-Transistor

Features

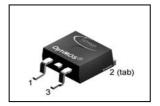
- N-channel Logic Level Enhancement mode
- Automotive AEC Q101 qualified
- MSL1 up to 260°C peak reflow
- 175°C operating temperature
- Green package (lead free)
- Ultra low Rds(on)

• 100% Avalanche tested

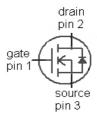
Product Summary

V _{DS}	55	V
R _{DS(on),max} (SMD version)	23	mΩ
I _D	30	Α

PG-TO252-3-11



Туре	Package	Marking
IPD30N06S2L-23	PG-TO252-3-11	2N06L23



Maximum ratings, at T_i =25 °C, unless otherwise specified

Parameter	Symbol	Conditions	Value	Unit
Continuous drain current ¹⁾	I _D	T _C =25 °C, V _{GS} =10 V	30	А
		T _C =100 °C, V _{GS} =10 V ²⁾	30	
Pulsed drain current ²⁾	I _{D,pulse}	T _C =25 °C	120	1
Avalanche energy, single pulse	E _{AS}	/ _D =30A	150	mJ
Gate source voltage	V_{GS}		±20	V
Power dissipation	P _{tot}	T _C =25 °C	100	W
Operating and storage temperature	$T_{\rm j},T_{\rm stg}$		-55 +175	°C
IEC climatic category; DIN IEC 68-1			55/175/56	



Parameter	Symbol	Conditions	Values		Unit	
			min.	typ.	max.	
Thermal characteristics						
Thermal resistance, junction - case	R _{thJC}		-	-	1.5	K/W
Thermal resistance, junction - ambient, leaded	$R_{ m thJA}$		-	-	100	
SMD version, device on PCB	R_{thJA}	minimal footprint	-	_	75	
		6 cm ² cooling area ³⁾	-	-	50	

Electrical characteristics, at $T_{\rm j}$ =25 °C, unless otherwise specified

Static characteristics

Drain-source breakdown voltage	$V_{(BR)DSS}$	V _{GS} =0 V, I _D = 1 mA	55	ı	ı	V
Gate threshold voltage	$V_{\rm GS(th)}$	$V_{\rm DS}=V_{\rm GS}, I_{\rm D}=50~\mu{\rm A}$	1.2	1.6	2.0	
Zero gate voltage drain current	I _{DSS}	$V_{\rm DS}$ =55 V, $V_{\rm GS}$ =0 V, $T_{\rm j}$ =25 °C	1	0.01	1	μΑ
		$V_{\rm DS}$ =55 V, $V_{\rm GS}$ =0 V, $T_{\rm j}$ =125 °C ²⁾	-	1	100	
Gate-source leakage current	I _{GSS}	V _{GS} =20 V, V _{DS} =0 V	-	1	100	nA
Drain-source on-state resistance	R _{DS(on)}	V _{GS} =4.5 V, I _D =22 A	1	20.0	30	mΩ
Drain-source on-state resistance	R _{DS(on)}	V _{GS} =10 V, I _D =22 A	-	15.9	23	mΩ



Parameter	Symbol Conditions		Values			Unit
			min.	typ.	max.	
Dynamic characteristics ²⁾						
Input capacitance	C iss		-	1091	-	pF
Output capacitance	Coss	$V_{\rm GS}$ =0 V, $V_{\rm DS}$ =25 V, f=1 MHz	-	310	-	
Reverse transfer capacitance	C _{rss}		-	107	-	
Turn-on delay time	t _{d(on)}		-	7	-	ns
Rise time	t _r	V _{DD} =30 V, V _{GS} =10 V,	-	22	-	
Turn-off delay time	t _{d(off)}	$I_{\rm D}$ =30 A, $R_{\rm G}$ =5 Ω	-	33	-	
Fall time	t _f	1	-	9	-	
Gate Charge Characteristics ²⁾	<u> </u>					_
Gate to source charge	Q _{gs}		-	4	5	nC
Gate to drain charge	Q _{gd}	V _{DD} =44 V, I _D =30 A,	-	11	16	
Gate charge total	Q _g	V _{GS} =0 to 10 V	-	33	42	
Gate plateau voltage	$V_{ m plateau}$		-	3.4	-	V
Reverse Diode						
Diode continous forward current ²⁾	Is	T -25 °C	-	-	30	А
Diode pulse current ²⁾	I _{S,pulse}	T _C =25 °C	-	-	120	
Diode forward voltage	V _{SD}	V _{GS} =0 V, I _F =30 A, T _j =25 °C	-	0.9	1.3	V
Reverse recovery time ²⁾	t _{rr}	V_R =30 V, I_F = I_S , di_F / dt =100 A/ μ s	-	47	-	ns
Reverse recovery charge ²⁾	Q _{rr}	V_R =30 V, I_F = I_S , di_F / dt =100 A/ μ s	-	45	-	nC

¹⁾ Current is limited by bondwire; with an RthJC=1.5 K/W the chip is able to carry 46.4 A. For detailed information see Application Note ANPS071E at www.infineon.com/optimos

²⁾ Defined by design. Not subject to production test.

 $^{^{3)}}$ Device on 40 mm x 40 mm x 1.5 mm epoxy PCB FR4 with 6 cm 2 (one layer, 70 μ m thick) copper area for drain connection. PCB is vertical in still air.



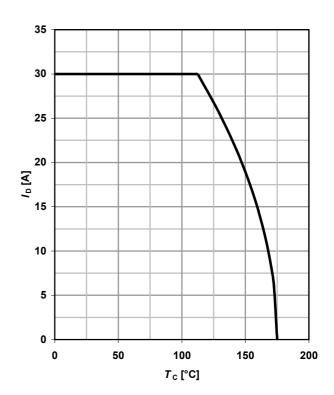
1 Power dissipation

$$P_{\text{tot}} = f(T_{\text{C}}); V_{\text{GS}} \ge 6 \text{ V}$$

100 80 80 40 40 20 0 50 100 150 200 T_c [°C]

2 Drain current

$$I_D = f(T_C); V_{GS} \ge 10 \text{ V}$$



3 Safe operating area

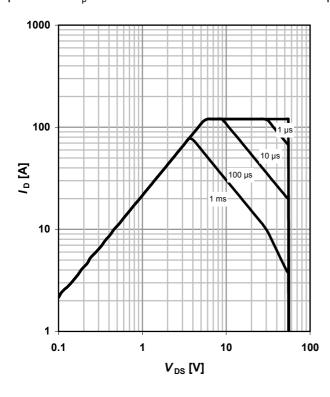
$$I_{\rm D} = f(V_{\rm DS}); T_{\rm C} = 25 \,^{\circ}{\rm C}; D = 0$$

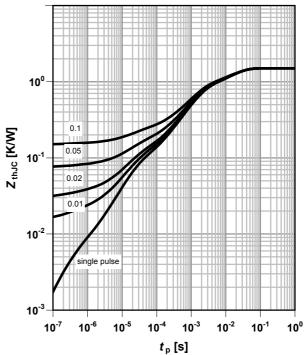
parameter: t_p

4 Max. transient thermal impedance

$$Z_{\rm thJC} = f(t_{\rm p})$$

parameter: $D = t_p/T$







5 Typ. output characteristics

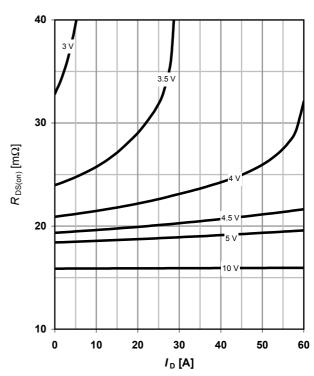
 $I_{\rm D} = f(V_{\rm DS}); T_{\rm j} = 25 \,{}^{\circ}{\rm C}$

parameter: $V_{\rm GS}$

6 Typ. drain-source on-state resistance

 $R_{DS(on)} = (I_D); T_j = 25 \text{ }^{\circ}\text{C}$

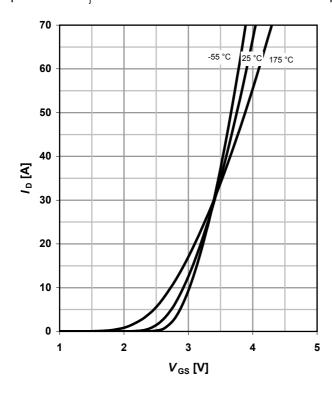
parameter: V_{GS}



7 Typ. transfer characteristics

 $I_D = f(V_{GS}); V_{DS} = 6V$

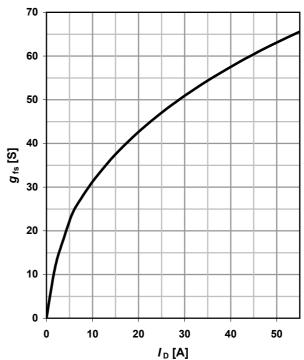
parameter: T_i



8 Typ. Forward transconductance

 $g_{fs} = f(I_D); T_j = 25^{\circ}C$

parameter: g fs

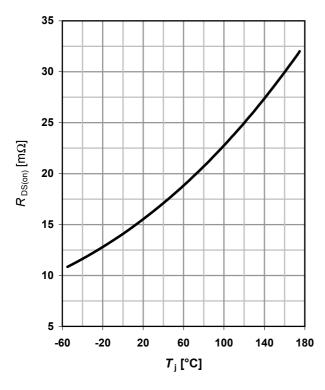




9 Typ. Drain-source on-state resistance

 $R_{DS(ON)} = f(T_i)$

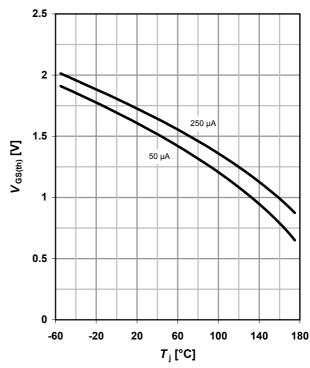
parameter: I_D = 22 A; V_{GS} = 10 V



10 Typ. gate threshold voltage

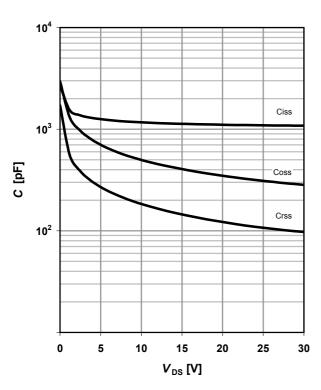
 $V_{GS(th)} = f(T_j); V_{GS} = V_{DS}$

parameter: I_D



11 Typ. capacitances

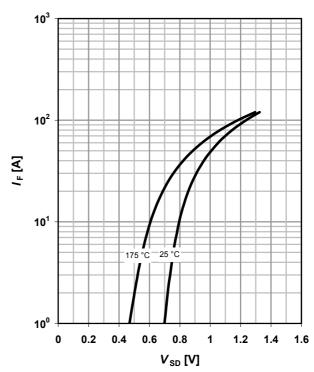
 $C = f(V_{DS}); V_{GS} = 0 V; f = 1 MHz$



12 Typical forward diode characteristicis

 $IF = f(V_{SD})$

parameter: T_i





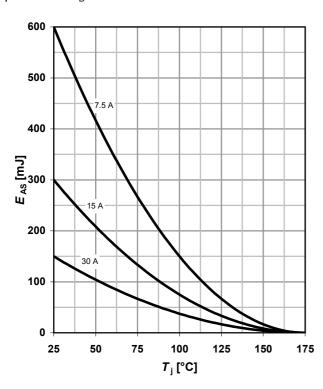
13 Typical avalanche energy

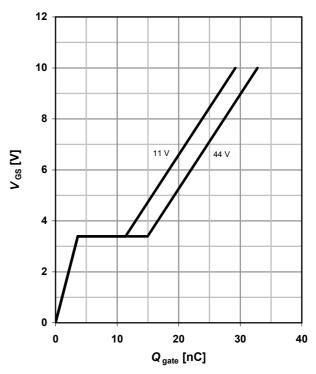
$E_{AS} = f(T_i)$

parameter: I_D

14 Typ. gate charge

$$V_{GS} = f(Q_{gate}); I_D = 30 A pulsed$$

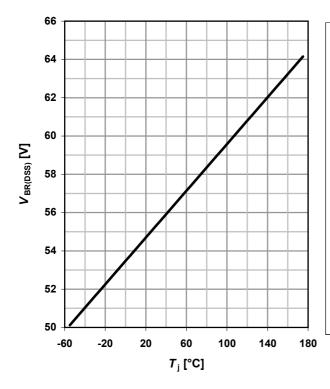


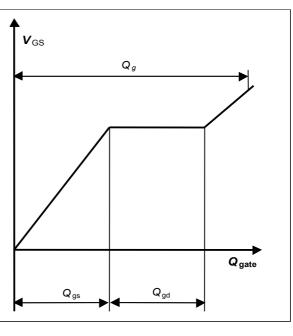


15 Typ. drain-source breakdown voltage

 $V_{BR(DSS)} = f(T_j); I_D = 1 \text{ mA}$

16 Gate charge waveforms







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